What Types of ECC Should Be Used on Flash Memory?

Application Note

1. Abstract

NOR Flash normally does not need ECC (Error-Correcting Code). On the other hand, NAND requires ECC to ensure data integrity. NAND Flash includes extra storage on each page to store ECC code as well as other information for wear-leveling, logical to physical block mapping, and other software overhead functions. The size of extra storage (spare area) is normally 16 byte per 512 byte sector but other sizes are also used. ECC algorithm correction strength (number of bit errors that can be corrected) depends on the ECC algorithm used to correct the errors (these algorithms may be implemented in either hardware or software). Simple Hamming codes can only correct single bit errors. Reed-Solomon code can correct more errors and is used on many of the current controllers. BCH (Bose, Ray-Chaudhuri, Hocquenghem) codes can also correct multiple bit errors and are becoming popular because of their improved efficiency over Reed-Solomon.

2. ECC Usage with Spansion's MS NAND Flash

Spansion® has created the industry's first charge-trapping 1.8V, 4-gigabit SLC NAND flash memory. This NAND memory is based on Spansion's MirrorBit® charge-trapping technology. The MS NAND flash guarantees that the first block is valid at factory shipment time and ensures an endurance of 100,000 Write/ Erase cycles with 1 bit ECC handling a partial page (528 bytes). It also guarantees a consistent 10-year data retention cycle.

It's important to note that since the MS NAND flash supports the Copy back function, some important considerations have to be taken into account by the host in order to avoid any possible accumulation of single bit errors. The host should make sure to implement either of the following scenarios:

- Readout of data to compute ECC (and modify data if needed) before writing it back. Actually, the data read from the source page can be read out by the host in order to compute error detection. Before copying back data to the device page, the host may perform data correction if needed. Since the data to be written is still in the page register, the host is required to upload only the corrected bytes using the “Change Write Column” command, making the sequence faster.
- Implement an ECC scheme that exceeds the minimum required ECC.

On the other hand, in order to ensure that the data is stored properly over the life of the MS NAND flash device, it is highly recommended that the following additional precautions be taken:

- Always check status after executing Write, Erase and Copyback operations.
- Implement bad-block management, garbage collection and wear-leveling algorithms.

3. Most Commonly Used ECC Algorithms

This section provides details of the three most commonly used ECC algorithms.

- Hamming Algorithm
- Reed-Solomon Algorithm
- Bose-Chaudhuri-Hocquenghem (BCH) algorithm

3.1 The Hamming Algorithm

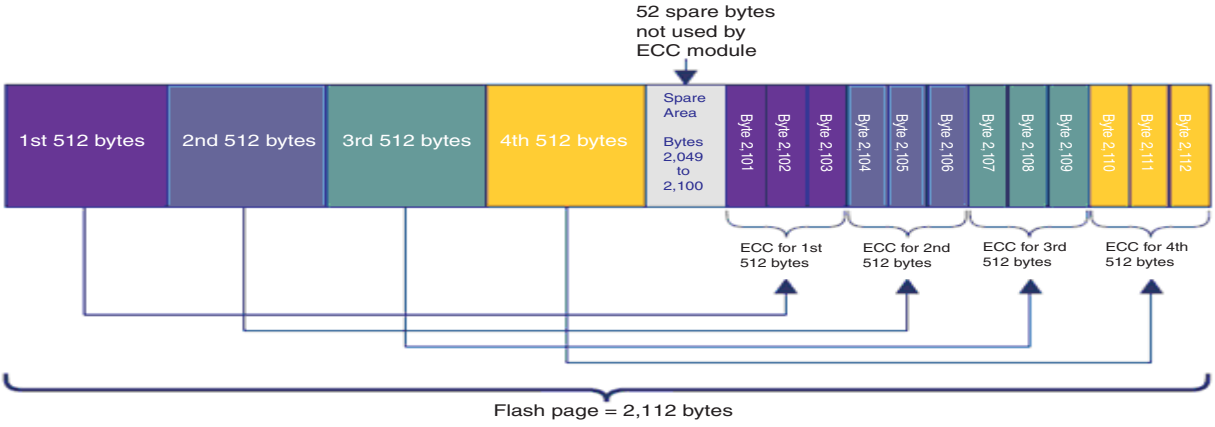
The Hamming algorithm is relatively straightforward and easy to be implemented in software or hardware. The limitation of Hamming algorithm is its limited error correction abilities. Hamming code is able to correct single bit errors and detect two bits errors. As to the S33MS NAND flash, the Hamming algorithm for ECC computation should be used only in case the host system would make sure to read back the source page to be copied using the Copy Back function and make all necessary bit corrections prior to writing it back, as explained in the previous section. A Hamming code is usually defined as (2^n-1, 2^n-n-1), where:

- n = the number of overhead bits
- 2^n-1 = the block size
- 2^n-n-1 = the number of data bits in the block

All Hamming codes can detect two errors and correct one error. Common Hamming code sizes are (7, 4), (15, 11), and (31, 26). Meaning in a 7-bit block only 4 bits are data, the other 3 bits are correction code; the same goes for (15,11) and (31,26).

For example, a NAND flash with 2 kB pages that uses a Hamming code algorithm may look like Figure 3.1.

Figure 3.1 NAND Storage of Hamming Code



In this configuration the Hamming code requires 3 bytes of ECC information for each 512-bytes sector, or 12 bytes (96 bits) of ECC encoding information is required per 2 kB page.

3.2 The Reed-Solomon Algorithm

The Reed-Solomon algorithm is often used on outer encoding while convolutional code is used on inner encoding (The inner code takes the result of the pre-coding operation and generates a sequence of encoding symbols. Each encoding symbol is the XOR of a randomly chosen set of symbols from the pre-code output). The convolutional code allows the correction of widely scattered errors but is not able to correct highly concentration errors. Reed-Solomon algorithm is often used in NAND flash memory interfaces.
Reed-Solomon codes are often used to handle NAND flash bit-flipping phenomenon. As to the S33MS NAND flash, Spansion recommends the implementation of the Reed-Solomon Algorithm. Reed-Solomon encoder uses Galois Field arithmetic operations to add parity symbols. Parameters are listed below:

- n = the number of code symbols
- s = gives the size of symbols (s-bit symbols). n=2^s-1
- t = number of correctable errors, 2*t is the number of parity check symbols
- k = number of message symbols (k=n-2t)

A Reed-Solomon code is specified as RS(n,k) with S-bit symbols.

n= k+2t = 2^s-1	
Data (k)	Parity (2t)

The decode process takes several stages to get error location and correct the error. The first decoding stage is syndrome computation; this stage transfers symbols to data syndrome. The decoder tells if errors are detected at this stage. After that, the algorithm computes error polynomial based on syndromes in the finite Galois field. Following stages find the roots of error polynomial to locate errors and correct them.

Example: A popular Reed-Solomon code is RS (255, 223) with 8-bit symbols. Each code word contains 255 code word bytes, of which 223 bytes are data and 32 bytes are parity. For this code:

n=255, k =223, s=8

2t=32, t=16

The decoder can correct any 16 symbol errors in the code word: i.e. errors up to 16 bits anywhere in the code word can be automatically corrected.

Currently, there are only a few micro-controllers that implement Reed-Solomon encoding, most of which are targeted to the USB or memory card applications, using a 4-byte-on-512-byte-page encoding specifically for MLC (Multi-Level Cell) NAND flash devices.

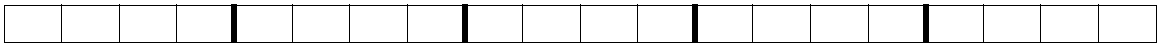
3.3 The BCH Algorithm

Hamming code provides the easiest hardware or software implementation; but it only corrects single bit errors. Reed-Solomon algorithm provides more robust error correction ability; but requires a large amount of system resources (CPU cycles or logic cells) to implement. Bose-Chaudhuri-Hocquenghem (BCH) algorithm is becoming popular because of its improved efficiency over Reed-Solomon algorithm. BCH code is a large class of multiple errors correcting codes. One advantage of BCH is that both highly concentrated and widely scattered errors are detected. Another advantage is that the encoding and decoding techniques are relatively simple compared to Reed-Solomon code. BCH codes belong to the class of linear block codes, to be more specific, the subclass of cyclic codes.

A block code consists of a set of vectors with N elements, where the vectors are called code word and N is called the length of the code word; q symbols are the elements of a code word. If the elements consist of the two symbols 1 and 0, the code is a binary code. A block code maps k information bit into a code word with length of N, and the ratio r = k/N is defined to be the rate of the code. As stated before, the elements of a code word are selected from an alphabet of q symbols. Codes are constructed from fields with q elements. In coding, q is usually a finite number, so the field is a finite field or a so called Galois field.

The main difference between Reed-Solomon and binary BCH is the underlying structures. Reed-Solomon algorithm is symbol-based and BCH algorithm is binary.

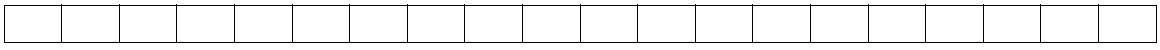
Reed-Solomon algorithm (Symbol base code)



Symbol 1 Symbol 2 Symbol 3 Symbol 4 Symbol 5

Symbol length = 4; code length = 5 symbols

BCH algorithm (binary base code)



Symbol length = 1; code length = 20 symbols

Both Reed-Solomon algorithm and BCH algorithm are common ECC choices for MLC NAND flash. Micro-controllers specially designed for SD Cards, SPI, eMMC and embedded NAND are becoming more common that use built-in hardware 6/9/12-bit BCH ECC circuits. Moreover, some MLC NAND flash devices have an

internal BCH ECC (Error Correction Code) generation engine, which can speed up data integrity checking. Extra command functions concerning embedded ECC are also provided in software drivers.

4. Conclusion

Hamming based block codes are the most commonly used ECC for SLC. Hamming codes are relatively straightforward and simple to be implemented in either software or hardware. The disadvantage of Hamming codes is its limited error correction capabilities, with two bit errors detection and only one bit error correction. Therefore, it is mainly used on SLC NAND flash application. As to the S33MS NAND flash, the Hamming algorithm for ECC computation should be used to some extent. For instance, this technique should be considered only in the case where the host system would make sure to read back the source page to be copied using the Copy Back function and make all necessary bit corrections prior to writing it back.

On the contrary, both Reed-Solomon and BCH are able to handle multiple errors and are widely used on MLC flash. It is also recommended to use these algorithms with the S33MS NAND flash since they ensure a reliable usage of the Copy Back function. Both codes are powerful and able to handle both random and burst errors. Reed-Solomon code is a subset of the BCH. However, BCH is simpler than Reed-Solomon to decode and implement. On the other hand, Reed-Solomon code is more suitable for concatenated codes.

5. Revision History

Section	Description
Revision 01 (November 27, 2007)	
	Initial release
Revision 02 (March 30, 2011)	
Global	Updated this document with references to Spansion's MS NAND flash

Colophon

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